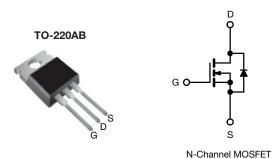
HALOGEN FREE



Power MOSFET



PRODUCT SUMMARY					
V _{DS} (V)	10	100			
R _{DS(on)} (Ω)	V _{GS} = 10 V	0.54			
Q _g max. (nC)	8	.3			
Q _{gs} (nC)	2	.3			
Q _{gd} (nC)	3	3.8			
Configuration	Sin	Single			

FEATURES

- Dynamic dV/dt rating
- Repetitive avalanche rated
- 175 °C operating temperature
- · Fast switching
- · Ease of paralleling
- Simple drive requirements
- Material categorization: for definitions of compliance please see <u>www.vishay.com/doc?99912</u>

Note

* This datasheet provides information about parts that are RoHS-compliant and / or parts that are non RoHS-compliant. For example, parts with lead (Pb) terminations are not RoHS-compliant. Please see the information / tables in this datasheet for details

DESCRIPTION

Third generation power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-220AB package is universally preferred for all commercial-industrial applications at power dissipation levels to approximately 50 W. The low thermal resistance and low package cost of the TO-220AB contribute to its wide acceptance throughout the industry.

ORDERING INFORMATION				
Package	TO-220AB			
Lead (Pb)-free	IRF510PbF			
Lead (Pb)-free and halogen-free	IRF510PbF-BE3			

PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-source voltage			V_{DS}	100	V	
Gate-source voltage			V_{GS}	± 20		
Continuous drain current	V _{GS} at 10 V	T _C = 25 °C	,	5.6		
		T _C = 100 °C	I _D	4.0	Α	
Pulsed drain current ^a			I _{DM}	20	1	
Linear derating factor				0.29	W/°C	
Single pulse avalanche energy ^b			E _{AS}	75	mJ	
Repetitive avalanche current a			I _{AR}	5.6	А	
Repetitive avalanche energy ^a			E _{AR} 4.3		mJ	
Maximum power dissipation	T _C =	25 °C	P_{D}	43	W	
Peak diode recovery dV/dt ^c			dV/dt	5.5	V/ns	
Operating junction and storage temperature range			T _J , T _{stg}	-55 to +175	°C	
Soldering recommendations (peak temperature) ^d	For 10 s			300		
Mounting torque	6-32 or M3 screw			10	lbf ⋅ in	
				1.1	N⋅m	

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11)
- b. $V_{DD} = 25$ V, starting $T_J = 25$ °C, L = 4.8 mH, $R_g = 25$ Ω , $I_{AS} = 5.6$ A (see fig. 12)
- c. $I_{SD} \le 5.6$ A, $dI/dt \le 75$ A/ μ s, $V_{DD} \le V_{DS}$, $T_J \le 175$ °C
- d. 1.6 mm from case



Vishay Siliconix

THERMAL RESISTANCE RATINGS					
PARAMETER	SYMBOL	TYP.	MAX.	UNIT	
Maximum junction-to-ambient	R _{thJA}	-	62		
Case-to-sink, flat, greased surface	R _{thCS}	0.50	-	°C/W	
Maximum junction-to-case (drain)	R _{thJC}	-	3.5		

PARAMETER	SYMBOL	TEST	MIN.	TYP.	MAX.	UNIT	
Static					•	•	
Drain-source breakdown voltage	V _{DS}	$V_{GS} = 0$	100	-	-	V	
V _{DS} temperature coefficient	$\Delta V_{DS}/T_{J}$	Reference	to 25 °C, I _D = 1 mA	-	0.12	-	V/°C
Gate-source threshold voltage	V _{GS(th)}	V _{DS} = \	$V_{DS} = V_{GS}, I_{D} = 250 \mu\text{A}$		-	4.0	V
Gate-source leakage	I _{GSS}	V _{GS} = ± 20 V		-	-	± 100	nA
-		V _{DS} = 100 V, V _{GS} = 0 V		-	-	25	μΑ
Zero gate voltage drain current	I _{DSS}	V _{DS} = 80 V, \	V _{DS} = 80 V, V _{GS} = 0 V, T _J = 150 °C		-	250	
Drain-source on-state resistance	R _{DS(on)}	V _{GS} = 10 V	I _D =3.4 A ^b	-	-	0.54	Ω
Forward transconductance	9 _{fs}		50 V, I _D = 3.4 A b	1.3	-	-	S
Dynamic							
Input capacitance	C _{iss}	$V_{GS} = 0 \text{ V},$ $V_{DS} = 25 \text{ V},$ $f = 1.0 \text{ MHz, see fig. 5}$		-	180	-	pF
Output capacitance	C _{oss}			-	81	-	
Reverse transfer capacitance	C _{rss}			-	15	-	
Total gate charge	Qq	V _{GS} = 10 V	$I_D = 5.6 \text{ A}, V_{DS} = 80 \text{ V}$ $V_{DS} = 10 \text{ V},$ see fig. 6 and fig. 13 b	-	-	8.3	nC
Gate-source charge	Q _{gs}			-	-	2.3	
Gate-drain charge	Q _{gd}			-	-	3.8	
Turn-on delay time	t _{d(on)}		1	-	6.9	-	
Rise time	t _r	V_{DD} = 50 V, I_{D} = 5.6 A R_{g} = 24 Ω , R_{D} = 8.4 Ω , see fig. 10 ^b		-	16	-	ns
Turn-off delay time	t _{d(off)}			-	15	-	
Fall time	t _f			-	9.4	-	
Gate input resistance	Rg	f = 1 MHz, open drain		2.5	-	11.6	Ω
Internal drain inductance	L _D	Between lead, 6 mm (0.25") from package and center of die contact		-	4.5	-	- nH
Internal source inductance	L _S			-	7.5	-	
Drain-Source Body Diode Characteristi	cs				•	•	
Continuous source-drain diode current	Is	MOSFET symbol showing the integral reverse p - n junction diode		-	-	5.6	Α
Pulsed diode forward current ^a	I _{SM}			-	-	20	
Body diode voltage	V_{SD}	T _J = 25 °C, I	$_{S} = 5.6 \text{ A}, V_{GS} = 0 \text{ V}^{\text{ b}}$	ı	-	2.5	V
Body diode reverse recovery time	t _{rr}	T 25 °C -	5.6.A. dl/dt = 100.A/va.b	-	100	200	ns
Body diode reverse recovery charge	Q_{rr}	$T_J = 25 ^{\circ}\text{C}, I_F = 5.6 \text{A}, \text{dI/dt} = 100 \text{A/}\mu\text{s}^{\text{b}}$		-	0.44	0.88	μC
Forward turn-on time	t _{on}	Intrinsic tur	n-on time is negligible (turi	n-on is do	minated	by L _S and	L _D)

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11)
- b. Pulse width \leq 300 µs; duty cycle \leq 2 %



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

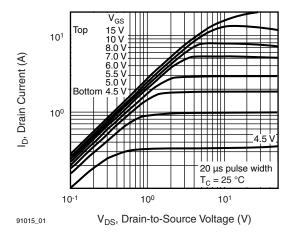


Fig. 1 - Typical Output Characteristics, T_C = 25 °C

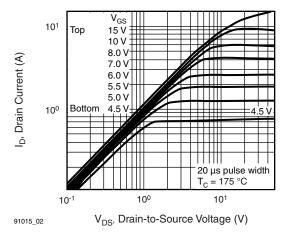


Fig. 2 - Typical Output Characteristics, $T_C = 175$ °C

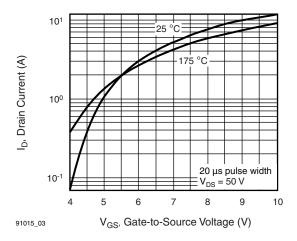


Fig. 3 - Typical Transfer Characteristics

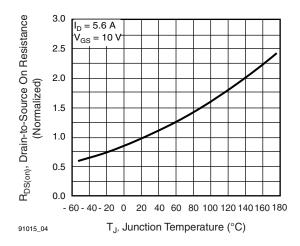


Fig. 4 - Normalized On-Resistance vs. Temperature

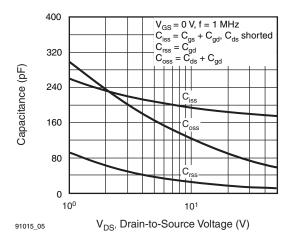


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

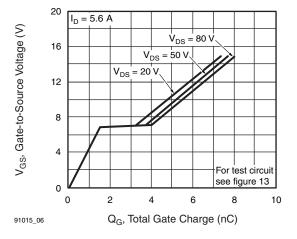


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage



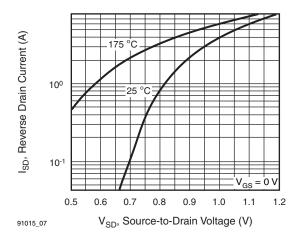


Fig. 7 - Typical Source-Drain Diode Forward Voltage

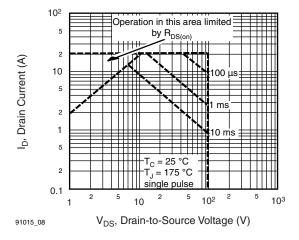


Fig. 8 - Maximum Safe Operating Area

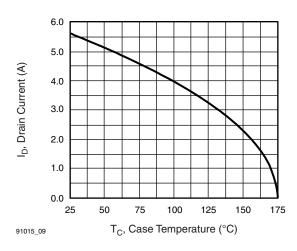


Fig. 9 - Maximum Drain Current vs. Case Temperature

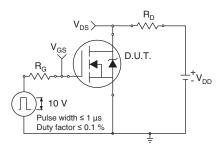


Fig. 10a - Switching Time Test Circuit

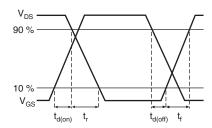


Fig. 10b - Switching Time Waveforms

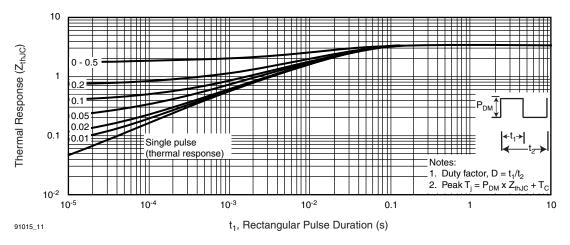


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case



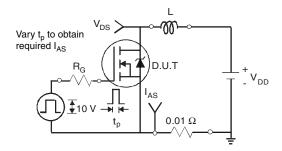


Fig. 12a - Unclamped Inductive Test Circuit

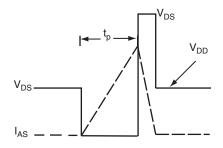


Fig. 12b - Unclamped Inductive Waveforms

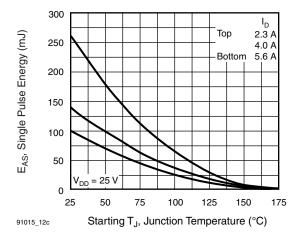


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

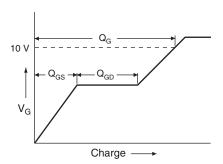


Fig. 13a - Basic Gate Charge Waveform

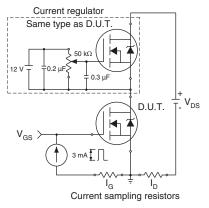


Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit

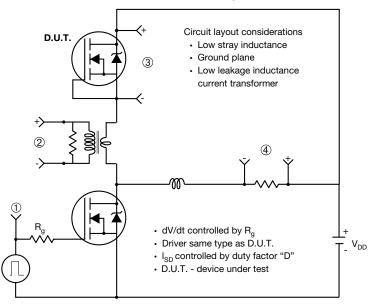




Fig. 14 - For N-Channel

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